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## **Supporting Information**

## 2 Water-promoted selective photocatalytic methane oxidation for methanol

## **3 production**

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## 13 Methods

Synthesis of *p*-type InGaN nanowires. *p*-type InGaN nanowires were grown on a 3-inch silicon wafer by 14 PAMBE technology.<sup>1, 2</sup> Silicon wafer was first cleaned with acetone and 10% buffered hydrofluoric acid. 15 Then the residual oxide on silicon wafer was removed by an in-situ annealing at ~787 °C in the reaction 16 chamber before growth. The InGaN NWs were spontaneously grown on silicon wafer under nitrogen-rich 17 conditions. Ga, In and Mg fluxes were controlled by using thermal effusion cells, while nitrogen radicals were 18 produced from a radio-frequency nitrogen plasma source. Multi-stack InGaN/GaN layers were grown on a 19 GaN layer and finally terminated by a GaN capping layer. A nitrogen flow rate of 1.0 sccm and a forward 20 plasma power of  $\sim$ 350 W were used in the growth process. 21

Cocatalyst loading. AgNPs were loaded on InGaN nanowires by a typical photoreduction process. In a 22 detailed process, a  $0.8 \text{ cm} \times 0.8 \text{ cm}$  photocatalyst wafer was stabilized on a Teflon holder which was put on 23 the bottom of one 390 mL Pyrex chamber containing 50 mL of 20vol% methanol aqueous solution. Then 10 24 µL of 0.2 mol L<sup>-1</sup> AgNO<sub>3</sub> (Sigma-Aldrich) was added into the chamber. The chamber equipped with a vacuum-25 tight quartz lid and a vacuum-tight plastic ring was evacuated before photoreduction. After that, the chamber 26 was irradiated for 20 mins under a 300 W Xe lamp (Cermax, PE300BUV). Finally, the photocatalyst wafer 27 was washed by deionized water and dried at 150 °C in argon atmosphere before photocatalytic methane 28 29 oxidation.

Characterization. The X-ray diffraction (XRD) pattern of photocatalyst wafer was obtained on a Rigaku X-30 ray diffractometer equipped with Cu Ka radiation working at the accelerating voltage of 40 kV, the current of 31 80 mA and the scanning rate of  $0.05^{\circ} 2\theta \text{ s}^{-1}$ . The microcosmic morphology of samples was examined by a 32 Hitachi SU8000 field emission scanning electron microscopy (FESEM) at an acceleration voltage of 10 kV. 33 The atomic-scale structures of as-prepared samples were analyzed on a double spherical aberration corrected 34 transmission electron microscopy (JEOL 3100R05) with a 300 kV accelerating voltage which generated the 35 high-resolution transmission electron microscopy (HRTEM) and high-angle annular dark field scanning 36 transmission electron microscopy (HAADF-STEM) images. PL measurements were taken with a HORIBA 37 iHR550 spectrometer and an excimer excitation source of 193 nm at a repetition rate of 200Hz. 38

Photocatalytic methane oxidation. Photocatalytic methane oxidation was performed in 390 mL Pyrex 39 chamber under a 300 Xe lamp (Figure S1). The as-prepared 0.8 cm  $\times$  0.8 cm photocatalyst wafer was put on 40 the bottom of reaction chamber. The intensity of concentrated light on the photocatalyst wafer was measured 41 to be 5,000 mW cm<sup>-2</sup> by a thermopile detector (919P, Newport Corporation). 5 mL deionized water was added 42 onto the bottom of chamber. Then feed gas consisting of methane and oxygen with different ratios was 43 introduced to the chamber at atmosphere pressure. The surface temperature of sample was measured by one 44 OMEGA RDXL4SD thermometer equipped with a thermocouple. During reaction, the surface temperature of 45 photocatalyst wafer was determined to be ~170 °C. The gas and liquid products in chamber was manually 46 sampled each 4 hours by using a syringe and analyzed in a gas chromatograph (Shimadzu GC-8A) equipped 47 with two flame ionization detectors. It should be noted that one flame ionization detector was equipped with 48 a methanizer for identifying and quantifying the carbon-based products, including ethane, CO, methanol and 49 CO<sub>2</sub>. The TOF for methanol was calculated by the following formula: 50

51  $TOF = Methanol production amount (mmol) \div photocatalyst amount (mmol) \div Time (hour)$ 

52 The mass density of Ga(In)N was 6.15 g cm<sup>-3</sup>. The amount of photocatalyst on 0.64 cm<sup>2</sup> silicon wafer used in

53 the photocatalytic methane reforming was calculated to be 5.64  $\mu$ mol (or 0.47 mg).

54 *In-situ* **DRIFTS.** The *In-situ* **DRIFTS** of photocatalytic methane oxidation on the as-prepared samples was

55 performed on an INVENIO-R Fourier transform infrared spectrometer equipped with a mercury cadmium

telluride (MCT) detector. The DRIFTS system consisted of a praying mantis diffuse reflectance accessory and 56 a reaction cell equipped with a heater (Harrick Scientific). Photocatalyst wafer was put in a sample cup inside 57 the reaction cell. A cover dome contained three windows: one made of quartz permitted the transmission of 58 UV-light beam during in situ reactions and two (ZnSe) for the entry and exit of detection infrared beam. Before 59 IR measurement, the samples were firstly pretreated at 300 °C for 30 min under Ar flow (20 sccm) to clear 60 catalyst surface. After that, the samples were cooled down to 170 °C which was the same as the test 61 temperature under 300 W Xe lamp. Then the sample was flushed by the methane and oxygen mixture with a 62 certain ratio at the total flow rate of 15 sccm. Meanwhile, the water vapor was introduced into the reaction 63 cell by treating the methane and oxygen mixture through a gas scrubber containing deionized water. A 365 64 nm LED lamp with a light intensity of 200 mW cm<sup>-2</sup> was used as the light source to photoexcite the sample. 65 During photocatalytic methane oxidation, the corresponding IR spectra were collected and converted to 66 Kubelka-Munk unit using Omnic<sup>™</sup> software. 67

68 Theoretical Simulation. The mechanism of photocatalytic methane oxidation on as-prepared samples was

69 studied by the Vienna Ab-initio Simulation Package (VASP). The revised Perdew-Burke-Ernzerh functional

70 of (RPBE) of the generalized gradient approximation (GGA) was used in the calculation of free energy. The

71 interaction between valence electrons and ionic core was described by the PAW pseudo-potential. The InGaN

surface was simulated by its typical stable (110) facet which consists of the  $3 \times 3$  supercell with four In/Ga-N layers. It should be noted that the ratio of In and Ga was 1:3 in slab layer according to the experimental PL result. The Ag nanoparticle on InGaN surface was simulated by one Ag cluster (31 atoms) with the diameter of ~1 nm. The convergence threshold of  $1.0 \times 10^{-4}$  eV Å<sup>-1</sup> and the cutoff of 400 eV were used in the geometry optimization at Gamma point. After geometry optimization, the projected density of states (PDOS) and charge density difference mappings were calculated with Monkhorst-Pack k-point mesh of  $2 \times 2 \times 1$ , the cutoff of

78 400 eV and energy convergence threshold of  $1.0 \times 10^{-5}$  eV.



Fig. S1 Reaction system for photocatalytic methane oxidation. (a) Image and (b) schematic illustration of reaction system.



 $CH_4 + H_2O$ **Fig. S2** Photocatalytic methanol production on AgNP-InGaN nanowires without oxygen.

![](_page_5_Figure_0.jpeg)

92 Fig. S3 Photocatalytic methanol production on pristine InGaN nanowires.

![](_page_6_Figure_0.jpeg)

Fig. S4 NMR spectra of methanol produced on AgNP-InGaN nanowires with  $H_2O$  or  $D_2O$ .

![](_page_7_Figure_0.jpeg)

105 Fig. S5 Activity of Ag/InGaN after 13 cycles.

![](_page_8_Figure_0.jpeg)

109 Fig. S6 XRD pattern of Ag/InGaN nanowires after 16 cycles.

![](_page_9_Picture_0.jpeg)

- 113 Fig. S7 HAADF-STEM of Ag/InGaN nanowires after 16 cycles.

![](_page_10_Picture_0.jpeg)

117 Fig. S8 FESEM images of Ag/InGaN nanowires after 16 cycles.

![](_page_11_Figure_0.jpeg)

![](_page_12_Figure_0.jpeg)

![](_page_12_Figure_1.jpeg)

125 Fig. S10 IR spectrum of pristine InGaN in the presence of CH<sub>4</sub>, O<sub>2</sub> and H<sub>2</sub>O under irradiation.

![](_page_13_Figure_0.jpeg)

![](_page_13_Figure_1.jpeg)

Fig. S11 IR spectrum of methanol desorption on Ag/InGaN (a) without and (b) with water. Ag/InGaN was 132 firstly pretreated before methanol adsorption and desorption measurement. The pretreatment method was same 133 to the above in-situ IR measurement. After pretreatment, the methanol was introduced onto the surface of 134 Ag/InGaN by an Ar carrier at a flow rate of 15 sccm through a gas scrubber containing methanol. After 135 adsorption equilibrium, the purge gas consisting of pure Ar was used to desorb methanol from Ag/InGaN. 136 During desorption process, the corresponding IR spectra were collected. For the water-promoted methanol 137 desorption, the purge gas consisting of Ar and water vapor was used. The IR peaks at 2940 cm<sup>-1</sup> and 2825 138 cm<sup>-1</sup> are assigned to the O-H and C-H bonds, respectively. 139

- 142 Table S1. State-of-the-art photocatalytic systems for reforming methane into methanol.
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Photocatalysts	Cocatalysts	Rate (mmol g <sup>-1</sup> h <sup>-1</sup> )	Stability (hours)	Year <sup>[Ref.]</sup>
<i>p</i> -InGaN	Ag	45.5	52	This work
ZnO	Pd	6.1	10	2019 <sup>[3]</sup>
TiO <sub>2</sub>	FeO <sub>x</sub>	0.35	11	2018 <sup>[4]</sup>
TiO <sub>2</sub>	Ag	4.8	8	2021 <sup>[5]</sup>
g-C <sub>3</sub> N <sub>4</sub>	Cu	0.11	2	2019[6]
ZnO	Co <sub>3</sub> O <sub>4</sub>	0.36	5	2022 <sup>[7]</sup>
ZnO/Fe <sub>2</sub> O <sub>3</sub>		0.18	30	2022 <sup>[8]</sup>
In <sub>2</sub> O <sub>3</sub>	Pd atom	0.10	15	2022 <sup>[9]</sup>
PMOF	RuFe(OH)	8.81	120	2022 <sup>[10]</sup>
bismuth vanadate		6.8	7	2021 <sup>[11]</sup>
UiO-66(2.5TFA)-Fe		0.26	1	2021 <sup>[12]</sup>

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